Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/682,542	WEE ET AL.	
Examiner	Art Unit	
X I Bautista	2179	

SEARCHED				
Class	Subclass	Date	Examiner	
same as	prior search	6/16/2007	ХВ	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST Search	6/18/2007	ХВ
IEEE Search		
Google Search		